

Notice of References Cited		Application/Control No. 10/511,727	Applicant(s)/Patent Under Reexamination NISHIO, AKIHIKO
		Examiner Bobbak Safaipour	Art Unit 2631

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*	B	US-2002/0061764 A1	05-2002	Kim et al.	455/522
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NON-PATENT DOCUMENTS

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